



Attorney Docket No.: 022193-060410US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Aaftab A. Munshi et al.

Application No.: 10/681,829

Filed: October 7, 2002

For: METHOD AND APPARATUS FOR IMPLEMENTING LEVEL OF DETAIL

WITH RAY TRACING

Examiner: Unassigned

Art Unit: 2671

INFORMATION DISCLOSURE

STATEMENT UNDER 37 CFR §1.97 and

§1.98

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

The references cited on attached form PTO/SB/08A are being called to the attention of the Examiner. In accordance with 37 CFR §1.98(d), copies of references AA-AC can be found in Application No. 09/898,034, filed 07/03/2001 (Attorney Docket No. 022193-060400US). Copies of references AD-AK are enclosed. It is respectfully requested that the cited references be expressly considered during the prosecution of this application, and the references be made of record therein and appear among the "references cited" on any patent to issue therefrom.

As provided for by 37 CFR 1.97(g) and (h), no inference should be made that the information and references cited are prior art merely because they are in this statement and no representation is being made that a search has been conducted or that this statement encompasses all the possible relevant information.

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Applicant believes that <u>no fee is required</u> for submission of this statement.

However, if a fee is required, the Commissioner is authorized to deduct such fee from the undersigned's Deposit Account No. 20-1430. Please deduct any additional fees from, or credit

any overpayment to, the above-noted Deposit Account.

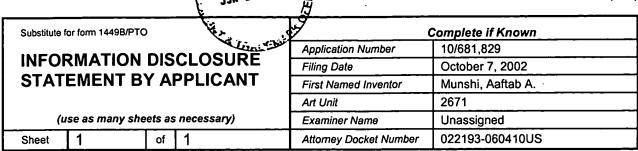
Respectfully submitted,

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PRJ:mbn 60238490 v1



U.S. PATENT DOCUMENTS+							
Examiner Initials*	Cite No.1		Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
	AA	US-5,831,620	11-03-1998	Kichury, Jr.			
	AB	US-6,091,422	07-18-2000	Ouaknine et al.			
	AC	US-6,400,372 B1	06-04-2002	. Gossweiler, III et al.			

Examiner	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the ite (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s),		
Initials *	No. ¹	publisher, city and/or country where published.	
	AD	"Procedural Models and Level of Detail"; Level of Detail Calculations and Models; Chapter 10; pp. 193-200.	
	AE	Alias Wavefront; "Maya API White Paper"; 1999; pp. 1-9.	
	AF	Avid Technology, Inc.; "Softimage 3D, Version 3.9.2"; 2000; 3 pages.	
	AG	Cinema Graphics, Inc.; "Displacement Shaders"; ShadeTree-RenderMan Tutorial ; 1998; pp. 1-3; Retrieved from the World Wide Web on April 13, 2001 at http://www.cinegrfx.com/newpages/prmantutorial/prman_displacement_shaders.html.	
	АН	Cinema Graphics, Inc.; "Light Shaders"; ShadeTree - RenderMan Tutorial; 1998; pp. 1-2; Retrieved from the World Wide Web on April 13, 2001 at http://www.cinegrfx.com/newpages/prman-tutorial/prman_light_shaders.html.	
	Al	Cinema Graphics, Inc.; "Surface Shaders"; ShadeTree - RenderMan Tutorial; 1998; pp. 1-3; Retrieved from the World Wide Web on April 13, 2001 at http://www.cinegrfx.com/newpages/prmantutorial/prman_surface_shaders.html.	
	AJ	Discreet Logic Inc.; "2D/3D Optimized Workflow"; 18 pages.	
	AK	Discreet Logic Inc.; "3ds max: Unleash Your Maximum Creativity, Release 4"; 2000; 4 pages.	

Examiner	Date]
Signature	Considered	J

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.